STP6N90K5



N-channel 900 V, 0.91 Ω typ., 6 A MDmesh™ K5 Power MOSFET in a TO-220 package

Datasheet - production data

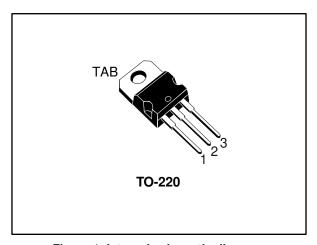
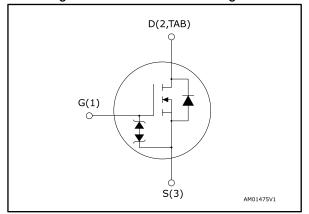


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	Ι _D
STP6N90K5	900 V	1.10 Ω	6 A

- Industry's lowest R_{DS(on)} x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STP6N90K5	6N90K5	TO-220	Tube

Contents STP6N90K5

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STP6N90K5 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 30	V
I_D	Drain current (continuous) at T _C = 25 °C	6	Α
I _D	Drain current (continuous) at T _C = 100 °C	4	Α
I _D ⁽¹⁾	I _D ⁽¹⁾ Drain current (pulsed)		Α
P _{TOT}	Total dissipation at T _C = 25 °C		W
dv/dt (2)	Peak diode recovery voltage slope	4.5	\//
dv/dt (3)	MOSFET dv/dt ruggedness	50	V/ns
Tj	Operating junction temperature range	FE to 150	°C
T _{stg}	Storage temperature range	- 55 to 150	10

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	1.14	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	62.5	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T_{jmax})	2	Α
Eas	Single pulse avalanche energy (starting T_j = 25 °C, I_D = I_{AR} , V_{DD} = 50 V)	210	mJ

⁽¹⁾Pulse width limited by safe operating area

 $^{^{(2)}}I_{SD} \leq 6$ A, di/dt \leq 100 A/ $\mu s;$ VDS peak < V(BR)DSS, VDD = 450 V.

 $^{^{(3)}}V_{DS} \le 720 \text{ V}$

Electrical characteristics STP6N90K5

2 Electrical characteristics

T_C = 25 °C unless otherwise specified

Table 5: On/off-state

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	900			V
	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 900 \text{ V}$			1	μΑ
I _{DSS}		$V_{GS} = 0 \text{ V}, V_{DS} = 900 \text{ V}$ $T_{C} = 125 \text{ °C}^{(1)}$			50	μΑ
Igss	Gate body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DD} = V_{GS}$, $I_D = 100 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 3 A		0.91	1.10	Ω

Notes:

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		1	342	1	pF
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	1	31	1	pF
Crss	Reverse transfer capacitance	$V_{GS} = 0 V$	-	1.2	-	pF
Co(tr) ⁽¹⁾	Equivalent capacitance time related	V _{DS} = 0 to 720 V,	-	55	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	V _{GS} = 0 V	-	20	-	pF
Rg	Intrinsic gate resistance	f = 1 MHz, I _D = 0 A	-	6.4	-	Ω
Qg	Total gate charge	$V_{DD} = 720 \text{ V}, I_D = 6 \text{ A}$	-	11	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	2.5	-	nC
Q _{gd}	Gate-drain charge	(see Figure 15: "Test circuit for gate charge behavior")	-	7	-	nC

Notes:

⁽¹⁾ Defined by design, not subject to production test.

 $^{^{(1)}}$ $C_{o(tr)}$ is a constant capacitance value that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DS}

 $^{^{(2)}}$ $C_{o(er)}$ is a constant capacitance value that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

Table 7: Switching times

Table 71 Officering times						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V_{DD} = 450 V, I_{D} = 3 A, R_{G} = 4.7 Ω	1	12.4	1	ns
tr	Rise time	V _{GS} = 10 V	1	12.2	1	ns
t _{d(off)}	Turn-off delay time	(see Figure 14: "Test circuit for resistive load switching times" and	-	30.4	-	ns
t _f	Fall time	Figure 19: "Switching time waveform")	-	15.5	-	ns

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		6	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		24	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 6 A, V _{GS} = 0 V	-		1.5	V
t _{rr}	Reverse recovery time	I _{SD} = 6 A, di/dt = 100 A/μs, V _{DD} = 60 V (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	342		ns
Q _{rr}	Reverrse recovery charge		-	3.13		μС
I _{RRM}	Reverse recovery current		-	18.3		Α
t _{rr}	Reverse recovery time	I _{SD} = 6 A, di/dt = 100 A/μs,	-	536		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V, T _j = 150 °C (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	4.42		μС
I _{RRM}	Reverse recovery current		-	16.5		Α

Notes:

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
$V_{(BR)GSO} \\$	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_D = 0 \text{ A}$	30	-	1	V	

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



⁽¹⁾Pulse width limited by safe operating area

 $^{^{(2)}\}text{Pulsed:}$ pulse duration = 300 $\mu\text{s},$ duty cycle 1.5%

2.1 Electrical characteristics (curves)

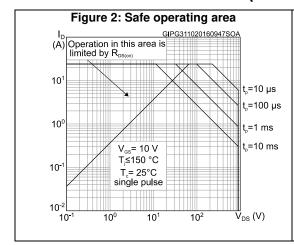
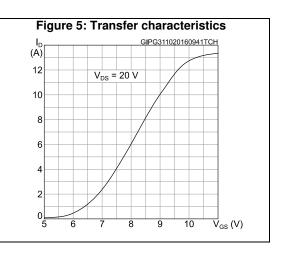
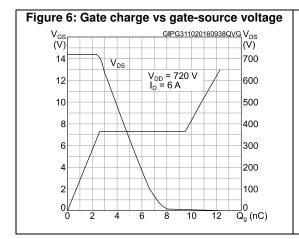


Figure 3: Thermal impedance $\begin{matrix} \mathsf{K} \\ \bar{\delta} = 0.5 \end{matrix} \\ \bar{\delta} = 0.2 \\ \bar{\delta} = 0.1 \\ \bar{\delta} = 0.01 \\ \bar{\delta} = 0.02 \\ \bar{\delta} = 0.01 \\ \bar{\delta} = 0.01 \\ \bar{\delta} = 0.02 \\ \bar{\delta} = 0.01 \\ \bar{\delta} = 0.02 \\ \bar{\delta} = 0.01 \\ \bar{\delta}$





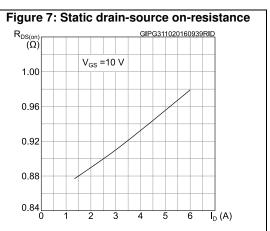
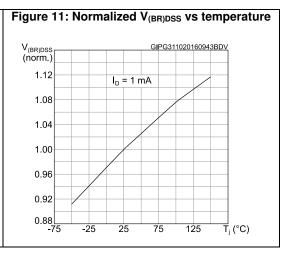


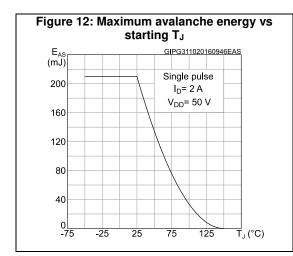
Figure 10: Normalized on-resistance vs temperature

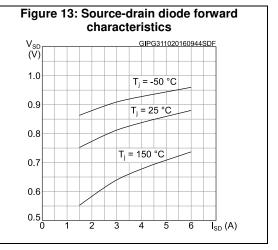
R_{DS(on)} GIPG311020160944RON

2.6 V_{GS} = 10 V

2.2 1.8 1.4 1.0 0.6 0.2 0.2 -75 -25 25 75 125 T_j (°C)







Test circuits STP6N90K5

3 Test circuits

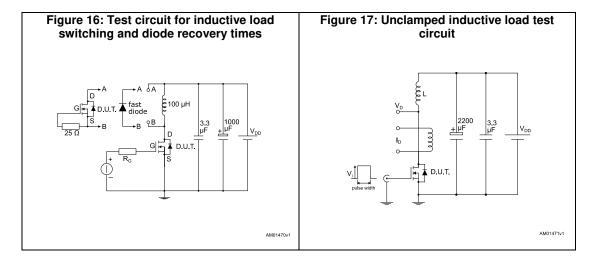
Figure 14: Test circuit for resistive load switching times

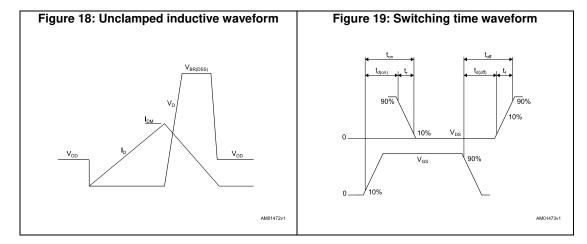
Figure 15: Test circuit for gate charge behavior

Figure 15: Test circuit for gate charge behavior

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Figure 15: Test circuit for gate charge behavior





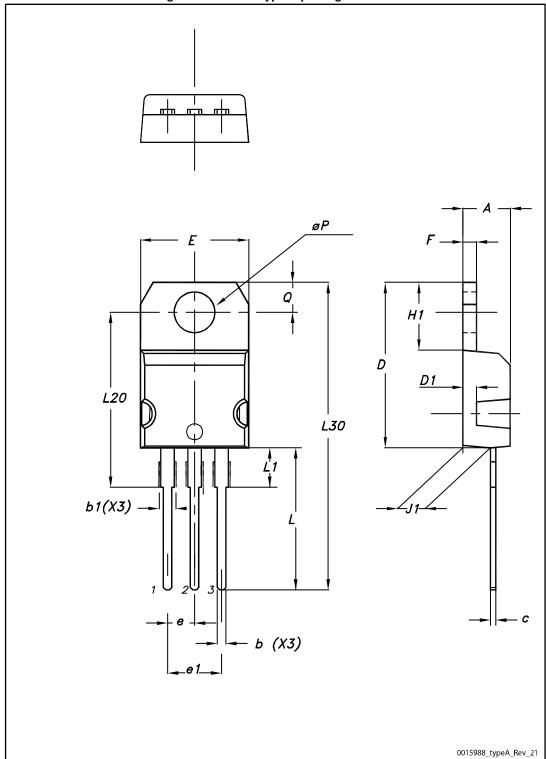
STP6N90K5 Package information

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-220 type A package information

Figure 20: TO-220 type A package outline



Н1

J1

L

L1

L20

L30 øP

Q

6.60

2.72

14.00

3.93

3.85

2.95

D:		•••••	
Dim.	Min.	Тур.	Max.
Α	4.40		4.60
b	0.61		0.88
b1	1.14		1.55
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10.00		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32

16.40 28.90

6.20

2.40

13.00

3.50

3.75

2.65

Table 10: TO-220 type A mechanical data

Revision history STP6N90K5

5 Revision history

Table 11: Document revision history

Date	Revision	Changes
02-Nov-2016	1	First release.

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